

Date of Publication Name of Patentee or Applicant of Cited Document of Cited Document Examiner Cite Number Kind Code No.1 Initials* MM-DD-YYYY (if known) 5,353,301 Mitzlaff 10-04-1994 Aβ

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ALEXANDER *EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

BOAKYE

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¹Unique citation designation number. ²See attached Kinds of U.S. Patent Documents. ³Enter Office that issued the document, by the two-letter code. *For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. 5Kind of document by the appropriate symbols as indicated on the document under WIPO Standard ST. 16 if possible. 6Applicant is to place a check mark here if English language translation is attached. AB indicates that only an English language abstract is attached.

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INFORMATION DISCLOSURE					Complete if Known						
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STATEMENT BY APPLICANT					First Named Inventor			Takamasa KOTAKE et al.			
						Art	Unit	2667			
						iner	Name	Alexander O. Boakye			
Sheet 1 of 1					Attorney Docket Number			2469-107			
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